

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TAKANO ET AL.	
		Examiner TAN TRINH	Art Unit 2684	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0132628 A1	09-2002	Matsumoto et al.	455/456
*	C	US-2002/0145991 A1	10-2002	Miya et al.	370/337
*	D	US-5,682,602	10-1997	Walker et al.	455/436
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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